



Contribution ID: 1263

Type: **Poster Presentation**

## **Wed-Af-Po3.17-05 [33]: Mechanical Design and Analysis of Capture Superconducting Magnet for EMuS**

*Wednesday 25 September 2019 14:00 (2 hours)*

An Experimental Muon Source (EMuS) is proposed to construct at the facility of China Spallation Neutron Source (CSNS) by IHEP (Beijing, China), for the R&D of key technologies of the next-generation neutrino beam facility. The capture superconducting solenoid magnet is one of the key components of the EMuS. It consists of 4 coils which are an axially graded solenoids with a peak central field of 5-T at 3944 A of nominal current. The capture magnet has an iron yoke for flux return and field shield. This paper presents the mechanical design and analysis of the capture magnet.

**Author:** Mr HOU, Zhilong (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences)

**Co-authors:** Prof. YUAN, Ye (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); Prof. TANG, Jingyu (Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); Dr ZHAO, Guang (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics); Prof. ZHU, Zian (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); Mr VASSILOPOULOS, Nikolaos (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) ); Dr JING, Hantao (Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); Dr ZHAO, Wei (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); XIE, Zongtai (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); Dr BAO, Yu (Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) ); Mr ZHANG, Guoqing (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); NING, Feipeng (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); CHEN, Yuan (Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) ); ZHAO, Ling (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); WANG, Meifen (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences); Mr LIU, Zhongxiu (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) )

**Presenter:** Mr HOU, Zhilong (The State Key Laboratory of Particle Detection and Electronics, Institute of High Energy Physics (IHEP) Chinese Academy of Sciences (CAS) , University of Chinese Academy of Sciences)

**Session Classification:** Wed-Af-Po3.17 - Mechanical Behavior II